

Notice of References Cited	Application/Control No. 10/505,212		Applicant(s)/Patent Under Reexamination GRAF ET AL.	
	Examiner Loha Ben		Art Unit 2873	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,911,529	03-1990	Van De Ven, Johannes C.	359/454
*	B	US-4,152,047	05-1979	Inoue, Yasuo	359/448
*	C	US-5,801,889	09-1998	Meyers et al.	359/743
*	D	US-5,751,387	05-1998	Iigahama et al.	349/95
*	E	US-5,448,382	09-1995	Land et al.	349/14
*	F	US-6,801,276 B1	10-2004	Epstein et al.	349/112
*	G	US-6,407,859 B1	06-2002	Hennen et al.	359/454
*	H	US-6,600,528 B2	07-2003	Colgan et al.	349/95
*	I	US-6,710,941 B2	03-2004	Hennen et al.	359/742
*	J	US-6,104,446	08-2000	Blankenbecler et al.	349/5
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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